

# STL85N6F3

## N-channel 60 V, 0.005 Ω, 19 A PowerFLAT™ (6x5) STripFET™ Power MOSFET

Preliminary Data

### Features

Туре	e V <sub>DSS</sub> R <sub>DS(on)</sub> max		I <sub>D</sub>
STL85N6F3	60 V	< 0.0057 Ω	19 A <sup>(1)</sup>

- 1. The value is rated according  $R_{thj-pcb}$
- Extremely low on-resistance R<sub>DS(on)</sub>
- 100% avalanche tested

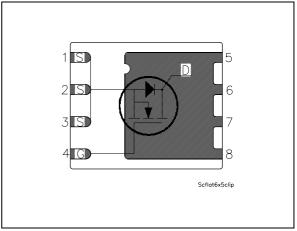
### Application

Switching applications

### Description

This N-channel enhancement mode Power MOSFET is the latest refinement of STMicroelectronics unique "single feature size" strip-based process with less critical alignment steps and therefore a remarkable manufacturing reproducibility. The resulting transistor shows extremely high packing density for low on resistance, rugged avalanche characteristics and low gate charge. TowerFLAT™ (6x5)

Figure 1. Internal schematic diagram



#### Table 1.Device summary

Order code	Marking	Package	Packaging
STL85N6F3	85N6F3	PowerFLAT™ (6x5)	Tape and reel

## Contents

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## **Electrical ratings**

Table 2. Absolute maximum	ratings
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Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)	60	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25°C	19	Α
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100°C	12	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	76	Α
I <sub>D</sub> <sup>(3)</sup>	Drain current (continuous) at T <sub>C</sub> =25°C	85	Α
$I_D^{(3)}$	Drain current (continuous) at T <sub>C</sub> = 100°C	54	Α
P <sub>TOT</sub> <sup>(1)</sup>	Total dissipation at $T_C = 25^{\circ}C$	4	W
P <sub>TOT</sub> <sup>(3)</sup>	Total dissipation at $T_C = 25^{\circ}C$	80	W
	Derating factor	0.03	W/°C
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

1. The value is rated according  $R_{thj-pcb}$ 

2. Pulse width limited by safe operating area

3. The value is rated according  $R_{thj-c}$ 

#### Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (drain) (steady state)	1.56	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-ambient	31.3	°C/W

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu, t < 10sec

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## 2 Electrical characteristics

(T<sub>CASE</sub>=25 °C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	60			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating @125°C			10 100	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	$V_{GS} = \pm 20 V$			±200	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	2			V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5A		0.005	0.0057	Ω

#### Table 4.On/off states

#### Table 5. Dynamic

	2 y name					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0		3400 650 60		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	V <sub>DD</sub> =30 V, I <sub>D</sub> = 19 A V <sub>GS</sub> =10 V <i>(see Figure 3)</i>		60 TBD TBD		nC nC nC



	officining timeo					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD}$ =15 V, I <sub>D</sub> = 8.5 A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =10 V (see Figure 2)		TBD TBD TBD TBD		ns ns ns ns

 Table 6.
 Switching times

#### Table 7. Source drain diode

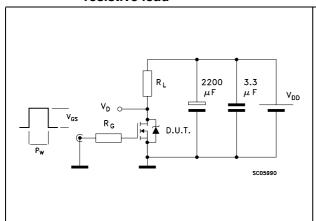
Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				19	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				76	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 19 A, V <sub>GS</sub> =0			1.3	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 19 A,		TBD		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/µs,		TBD		nC
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> =25 V, Tj=150°C		TBD		А

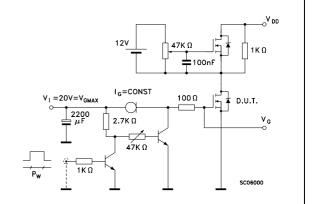
1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300µs, duty cycle 1.5%

### 3 Test circuit

Figure 2. Switching times test circuit for resistive load

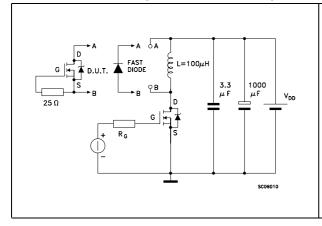


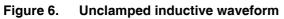


Gate charge test circuit

Figure 3.

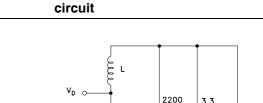
Figure 4. Test circuit for inductive load Figure 5. switching and diode recovery times



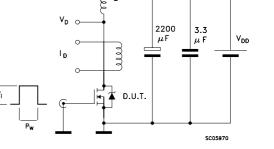


 $|_{D}$ 

 $V_{DD}$ 



**Unclamped inductive load test** 



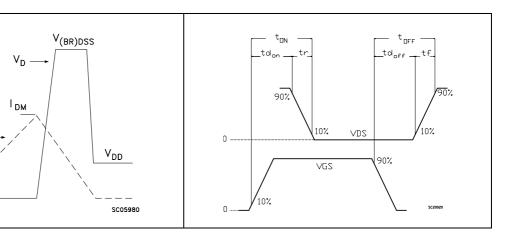


Figure 7. Switching time waveform

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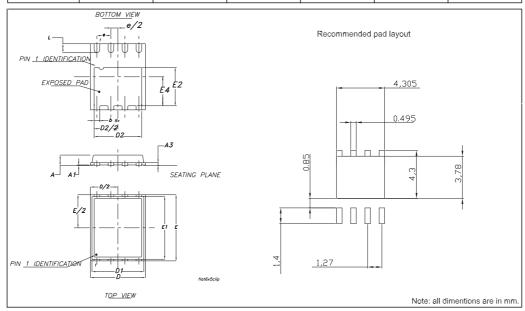
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.



DIM.		mm.			inch		
DINI.	Min.	Тур.	Max.	Min.	Тур.	Max.	
А	0.80	0.83	0.93	0.031	0.32	0.036	
A1		0.02	0.05		0.0007	0.0019	
A3		0.20			0.007		
b	0.35	0.40	0.47	0.013	0.015	0.018	
D		5.00			0.196		
D1		4.75			0.187		
D2	4.15	4.20	4.25	0.163	0.165	0.167	
E		6.00			0.236		
E1		5.75			0.226		
E2	3.43	3.48	3.53	0.135	0.137	0.139	
E4	2.58	2.63	2.68		0.103	0.105	
е		1.27			0.050		
L	0.70	0.80	0.90	0.027	0.031	0.035	

PowerFLAT<sup>™</sup>(6x5) mechanical data





## 5 Revision history

### Table 8. Document revision history

Date	Revision	Changes
22-Jan-2009	1	First release



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